

# EVVOSEMI<sup>®</sup>

THINK CHANGE DO



ESD



TVS



MOS



LDO



Diode



Sensor



DC-DC

## Product Specification

|              |             |           |
|--------------|-------------|-----------|
| ▶ Domestic   | Part Number | IRLML2402 |
| ▶ Overseas   | Part Number | IRLML2402 |
| ▶ Equivalent | Part Number | IRLML2402 |

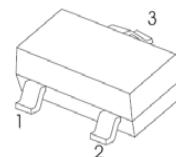
EV is the abbreviation of name EVVO

## N-Channel MOSFET

### Product summary

|                                           |            |           |
|-------------------------------------------|------------|-----------|
| $V_{DS}$                                  | <b>20</b>  | <b>V</b>  |
| $R_{DS(on) \max}$<br>(@ $V_{GS} = 4.5V$ ) | <b>250</b> | <b>mΩ</b> |
| $Q_g$ (typical)                           | <b>2.6</b> | <b>nC</b> |
| $I_D$<br>(@ $T_A = 25^\circ C$ )          | <b>1.2</b> | <b>A</b>  |

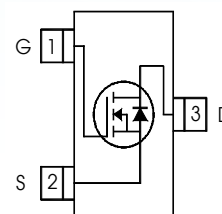
### SOT-23



- 1. GATE
- 2. SOURCE
- 3. DRAIN

### Features

- Industry-standard pinout SOT-23 Package
- Compatible with Existing Surface Mount Techniques
- RoHS Compliant, Halogen-Free
- MSL1, Industrial qualification



### Absolute Maximum Ratings

|                          | Parameter                                 | Max.         | Units |
|--------------------------|-------------------------------------------|--------------|-------|
| $I_D @ T_A = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ 4.5V$ | 1.2          | A     |
| $I_D @ T_A = 70^\circ C$ | Continuous Drain Current, $V_{GS} @ 4.5V$ | 0.95         |       |
| $I_{DM}$                 | Pulsed Drain Current ①                    | 7.4          |       |
| $P_D @ T_A = 25^\circ C$ | Power Dissipation                         | 540          | mW    |
|                          | Linear Derating Factor                    | 4.3          | mW/°C |
| $V_{GS}$                 | Gate-to-Source Voltage                    | $\pm 12$     | V     |
| dv/dt                    | Peak Diode Recovery dv/dt ②               | 5.0          | V/ns  |
| $T_J, T_{STG}$           | Junction and Storage Temperature Range    | -55 to + 150 | °C    |

### Thermal Resistance

|                 | Parameter                     | Typ. | Max. | Units |
|-----------------|-------------------------------|------|------|-------|
| $R_{\theta JA}$ | Maximum Junction-to-Ambient ④ | —    | 230  | °C/W  |

## N-Channel MOSFET

### Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

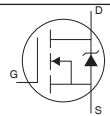
|                                 | Parameter                            | Min. | Typ.  | Max. | Units   | Conditions                                           |
|---------------------------------|--------------------------------------|------|-------|------|---------|------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 20   | —     | —    | V       | $V_{GS} = 0V, I_D = 250\mu A$                        |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.024 | —    | V/°C    | Reference to $25^\circ\text{C}$ , $I_D = 1mA$        |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —     | 250  | mΩ      | $V_{GS} = 4.5V, I_D = 0.93A$ ③                       |
|                                 |                                      | —    | —     | 350  |         | $V_{GS} = 2.7V, I_D = 0.47A$ ③                       |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 0.70 | —     | —    | V       | $V_{DS} = V_{GS}, I_D = 250\mu A$                    |
| $g_{fs}$                        | Forward Transconductance             | 1.3  | —     | —    | S       | $V_{DS} = 10V, I_D = 0.47A$                          |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —     | 1.0  | $\mu A$ | $V_{DS} = 16V, V_{GS} = 0V$                          |
|                                 |                                      | —    | —     | 25   |         | $V_{DS} = 16V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —     | -100 | nA      | $V_{GS} = -12V$                                      |
|                                 | Gate-to-Source Reverse Leakage       | —    | —     | 100  |         | $V_{GS} = 12V$                                       |
| $Q_g$                           | Total Gate Charge                    | —    | 2.6   | 3.9  | nC      | $I_D = 0.93A$                                        |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | 0.41  | 0.62 |         | $V_{DS} = 16V$                                       |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | 1.1   | 1.7  |         | $V_{GS} = 4.5V$ , See Fig. 6 and 9 ③                 |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 2.5   | —    | ns      | $V_{DD} = 10V$                                       |
| $t_r$                           | Rise Time                            | —    | 9.5   | —    |         | $I_D = 0.93A$                                        |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 9.7   | —    |         | $R_G = 6.2\Omega$                                    |
| $t_f$                           | Fall Time                            | —    | 4.8   | —    | pF      | $R_D = 11\Omega$ , See Fig. 10 ③                     |
| $C_{iss}$                       | Input Capacitance                    | —    | 110   | —    |         | $V_{GS} = 0V$                                        |
| $C_{oss}$                       | Output Capacitance                   | —    | 51    | —    |         | $V_{DS} = 15V$                                       |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 25    | —    |         | $f = 1.0MHz$ , See Fig. 5                            |

### Source-Drain Ratings and Characteristics

|          | Parameter                                 | Min. | Typ. | Max. | Units | Conditions                                                              |
|----------|-------------------------------------------|------|------|------|-------|-------------------------------------------------------------------------|
| $I_S$    | Continuous Source Current<br>(Body Diode) | —    | —    | 0.54 | A     | MOSFET symbol<br>showing the<br>integral reverse<br>p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current<br>(Body Diode) ①   | —    | —    | 7.4  |       |                                                                         |
| $V_{SD}$ | Diode Forward Voltage                     | —    | —    | 1.2  | V     | $T_J = 25^\circ\text{C}, I_S = 0.93A, V_{GS} = 0V$ ③                    |
| $t_{rr}$ | Reverse Recovery Time                     | —    | 25   | 38   | ns    | $T_J = 25^\circ\text{C}, I_F = 0.93A$                                   |
| $Q_{rr}$ | Reverse Recovery Charge                   | —    | 16   | 24   | nC    | $di/dt = 100A/\mu s$ ③                                                  |

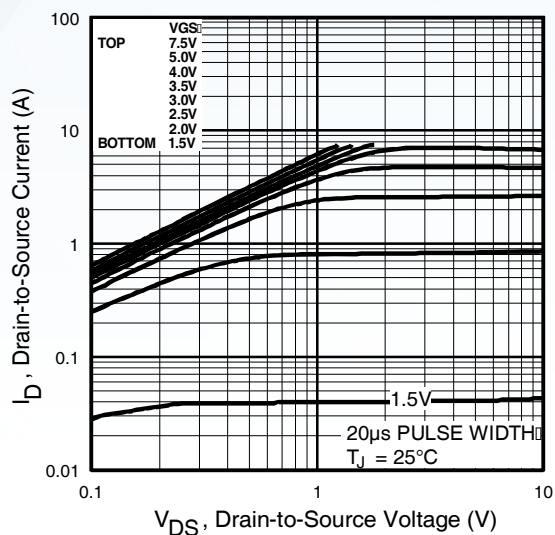
#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ②  $I_{SD} \leq 0.93A$ ,  $di/dt \leq 90A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ\text{C}$
- ③ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .
- ④ Surface mounted on FR-4 board,  $t \leq 5sec$ .

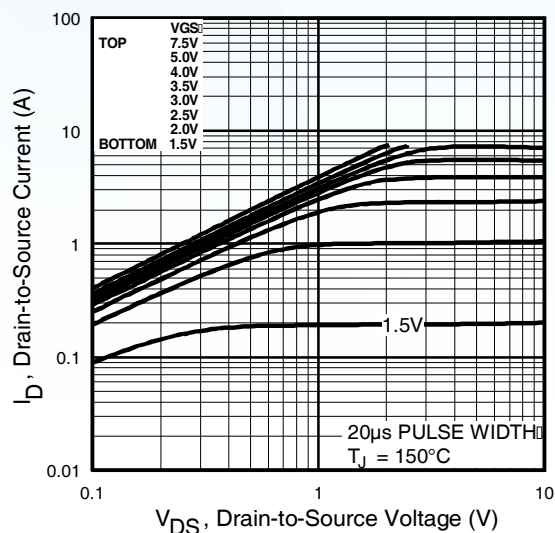


## N-Channel MOSFET

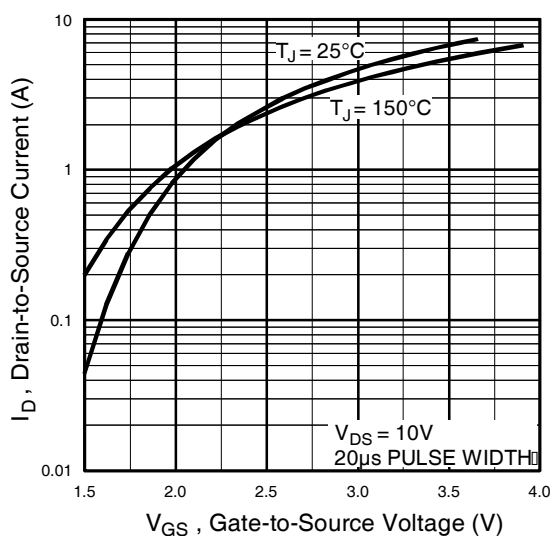
### Typical Characteristics



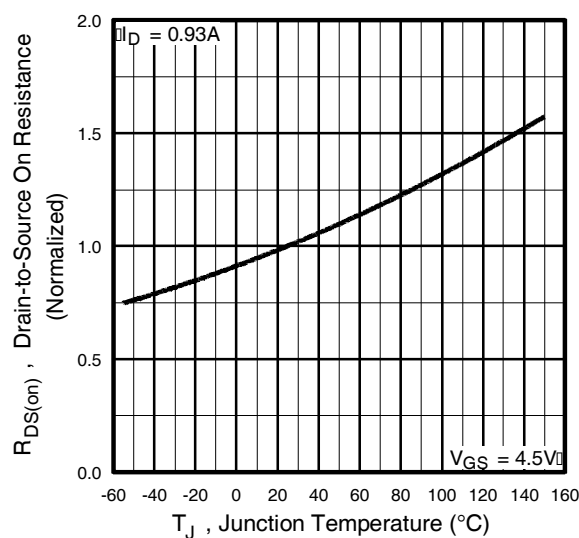
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



**Fig 3.** Typical Transfer Characteristics



**Fig 4.** Normalized On-Resistance Vs. Temperature

N-Channel MOSFET

Typical Characteristics

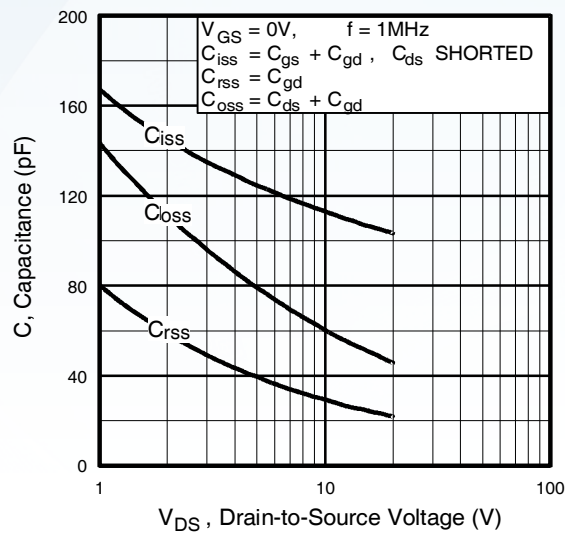


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

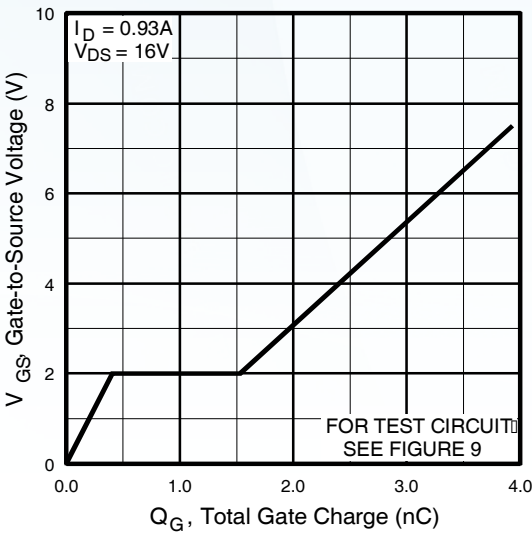


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

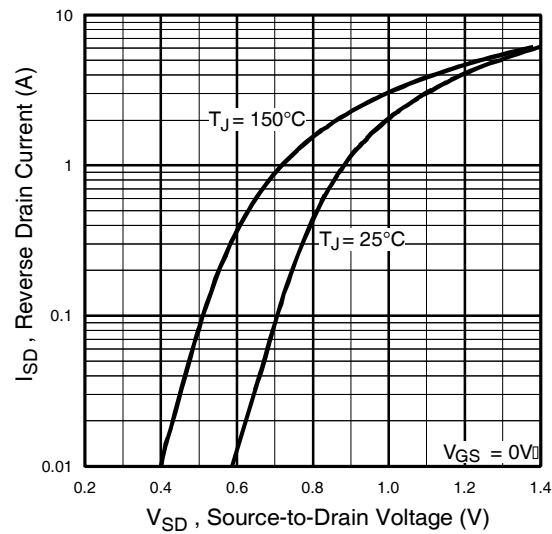


Fig 7. Typical Source-Drain Diode Forward Voltage

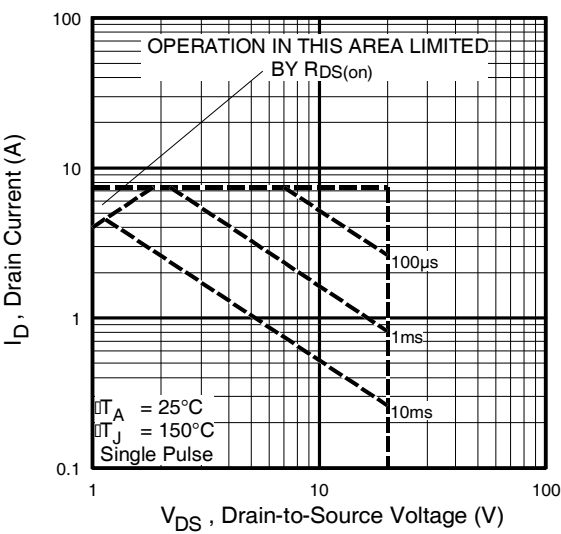


Fig 8. Maximum Safe Operating Area

N-Channel MOSFET

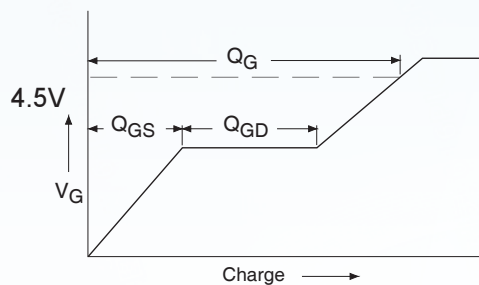


Fig 9a. Basic Gate Charge Waveform

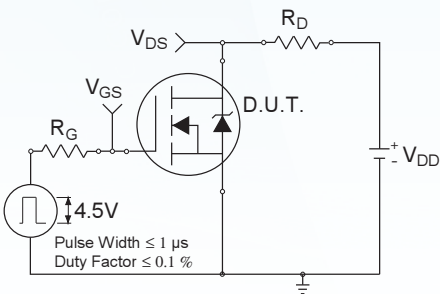


Fig 10a. Switching Time Test Circuit

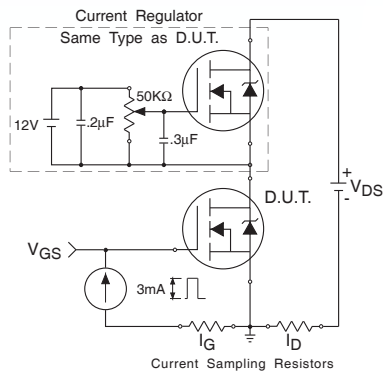


Fig 9b. Gate Charge Test Circuit

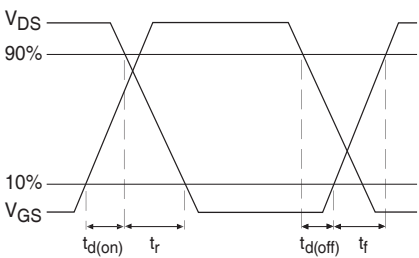


Fig 10b. Switching Time Waveforms

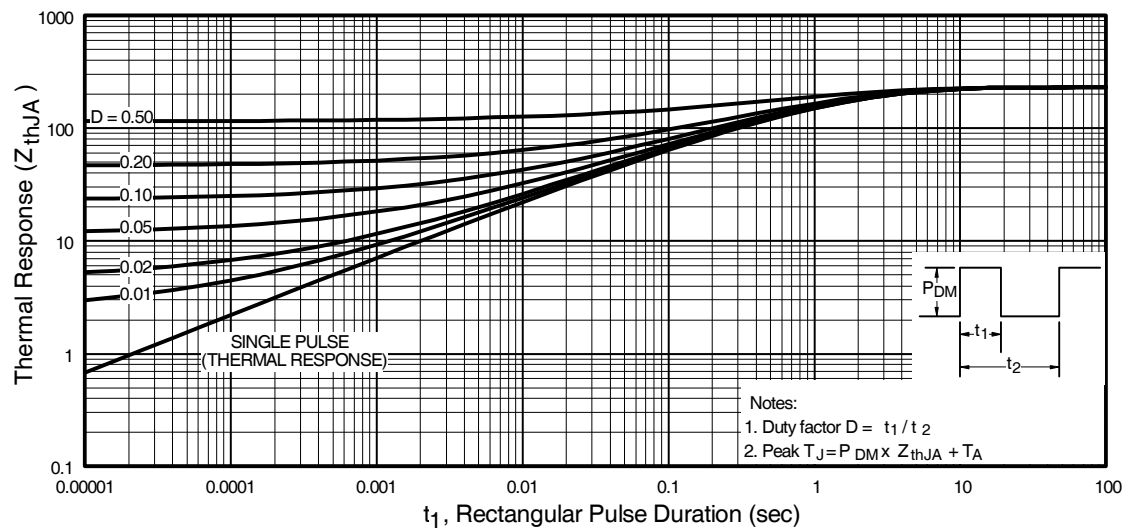


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

## N-Channel MOSFET

## Peak Diode Recovery dv/dt Test Circuit

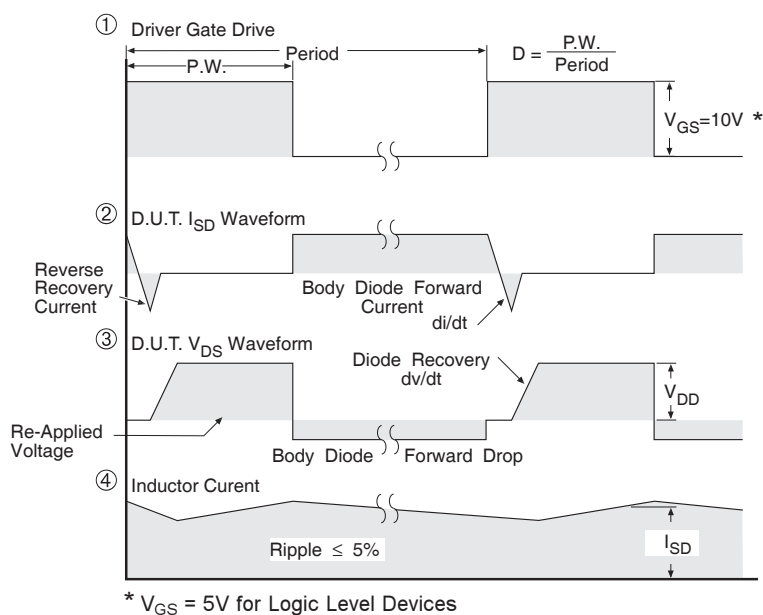
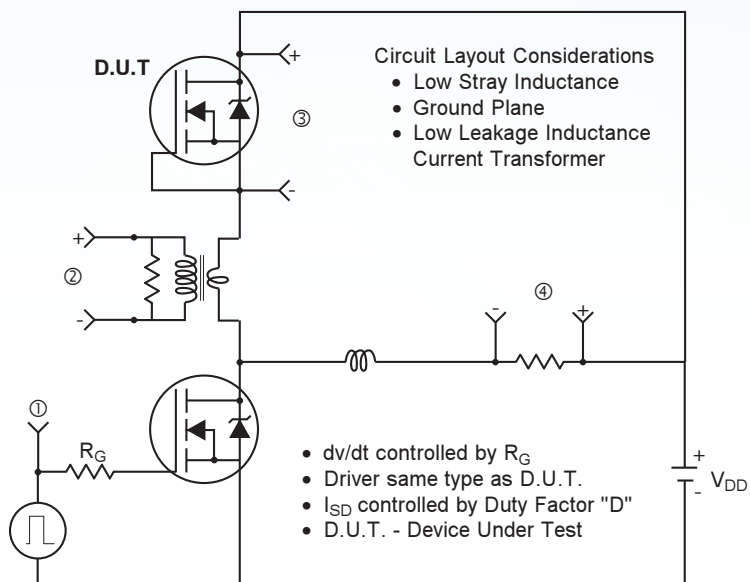
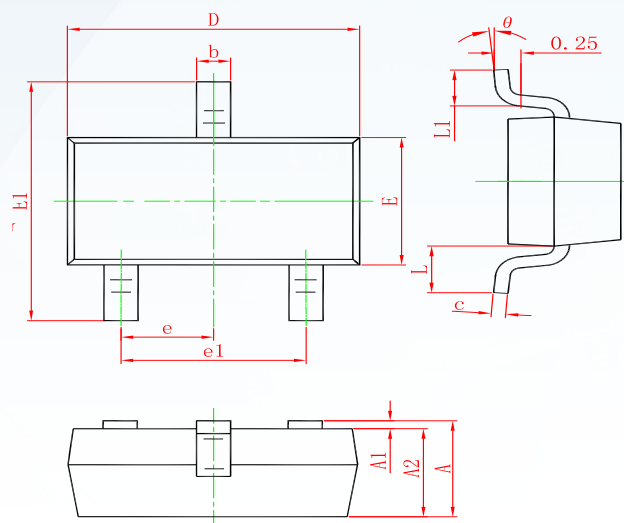


Fig 12. For N-Channel HEXFETS

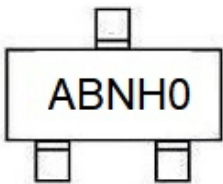
N-Channel MOSFET

SOT-23 PACKAGE OUTLINE DIMENSIONS



| Symbol | Dimensions In Millimeters |       | Dimensions In Inches |       |
|--------|---------------------------|-------|----------------------|-------|
|        | Min.                      | Max.  | Min.                 | Max.  |
| A      | 0.900                     | 1.150 | 0.035                | 0.045 |
| A1     | 0.000                     | 0.100 | 0.000                | 0.004 |
| A2     | 0.900                     | 1.050 | 0.035                | 0.041 |
| b      | 0.300                     | 0.500 | 0.012                | 0.020 |
| c      | 0.080                     | 0.150 | 0.003                | 0.006 |
| D      | 2.800                     | 3.000 | 0.110                | 0.118 |
| E      | 1.200                     | 1.400 | 0.047                | 0.055 |
| E1     | 2.250                     | 2.550 | 0.089                | 0.100 |
| e      | 0.950 TYP.                |       | 0.037 TYP.           |       |
| e1     | 1.800                     | 2.000 | 0.071                | 0.079 |
| L      | 0.550 REF.                |       | 0.022 REF.           |       |
| L1     | 0.300                     | 0.500 | 0.012                | 0.020 |
| θ      | 0°                        | 8°    | 0°                   | 8°    |

Marking



Ordering information

| Order code | Package | Baseqty | Deliverymode  |
|------------|---------|---------|---------------|
| IRLML2402  | SOT-23  | 3000    | Tape and reel |

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